






Substitute for form 1449A/B/PTO				<b>Complete if Known</b>	
<b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b>  (Use as many sheets as necessary)				Application Number	Not Yet Assigned
				Filing Date	November 24, 2003
				First Named Inventor	Dinesh Chopra
				Art Unit	N/A
				Examiner Name	Not Yet Assigned
Sheet	1	of	1	Attorney Docket Number	M4065.0152/P152-C

U.S. PATENT DOCUMENTS					
Examiner Initials*	Cite No. <sup>1</sup>	Document Number	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Number-Kind Code <sup>2</sup> (if known)			
	A	US-5,486,131	1/23/96	Cesna et al.	
	B	US-5,527,424	6/18/96	Mullins	
	C	US-5,611,943	3/18/97	Cadien et al.	
	D	US-5,655,951	8/12/97	Meikle et al.	
	E	US-5,664,987	09/09/97	Renteln	
	F	US-5,775,983	07/07/98	Shendon et al.	
	G	US-5,779,526	07/14/98	Gill	
	H	US-5,785,585	07/28/98	Manfredi et al.	
	I	US-5,830,043	11/03/98	Aaron et al.	
	J	US-6,039,633	03/00	Chopra	
	K	US-5,759,089	06/98	McCoy	
	L	US-5,997,384	12/99	Balock	
	M	US-5,860,853	01/99	Hasegawa et al.	
	N	US-5,692,947	12/97	Taileh et al.	
	O	US-5,643,044	07/97	Lund	
	P	US-5,934,974	08/99	Tzeng	
	Q	US-5,980,368	11/99	Chang et al.	
	R	US-5,707,492	01/98	Stager et al.	
	S	US-4,052,243	10/77	Yazawa et al.	
	T	US-5,961,372	10/99	Shendon	
	U	US-6,093,080	07/00	Inaba et al.	
	V	US-6,312,319	11/01	Donohue et al.	
	W	US-2003/0013384	01/03	Donohue et al.	

FOREIGN PATENT DOCUMENTS						
Examiner Initials*	Cite No. <sup>1</sup>	Foreign Patent Document	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T <sup>6</sup>
		Country Code <sup>3</sup> -Number <sup>4</sup> -Kind Code <sup>5</sup> (if known)				
	X	EP0770455A1	2/5/97			
	Y	EP96307780.5	5/97			
	Z	JP-10029157-A	02/98			
	AA	JP-05057606-A	03/93			
	AB	JP-10233421-A	09/98			

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant. <sup>1</sup> Applicant's unique citation designation number (optional). <sup>2</sup> See Kinds Codes of USPTO Patent Documents at [www.uspto.gov](http://www.uspto.gov) or MPEP 901.04. <sup>3</sup> Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). <sup>4</sup> For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. <sup>5</sup> Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST.16 if possible. <sup>6</sup> Applicant is to place a check mark here if English language Translation is attached.

NON PATENT LITERATURE DOCUMENTS			
Examiner Initials	Cite No. <sup>1</sup>	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T <sup>2</sup>

Examiner Signature	Date Considered	4/3/04
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